Power MOSFET

30 V, 12.3 A, Single N-Channel, SO-8

Features

- Low R_{DS(on)}
- Low Gate Charge
- Standard SO-8 Single Package
- Pb-Free Package is Available

Applications

- Notebooks, Graphics Cards
- Synchronous Rectification
- High Side Switch
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage			V_{GS}	±20	٧
Continuous Drain Current (Note 1)	Steady State	$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	ID	7.3	Α
	t ≤ 10 s	$T_A = 85^{\circ}C$		12.3	C
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	1.6	(\$
	t ≤ 10 s			2.3	
Continuous Drain Current (Note 2)	Steady State	$T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	7.6 5.4	Α
Power Dissipation (Note 2)		T _A = 25°C	P _D	0.86	W
Pulsed Drain Current	t _p =	: 10 μs	I _{DM}	37	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 150	ç
Source Current (Body Diode)			ls	2.3	Α
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 25 V, V_{GS} = 10 V, I_L Peak = 7.5 A, L = 10 mH, R_G = 25 Ω)			E _{AS}	200	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 secs)			TL	260	°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80.5	°C/W
$Junction-to-Ambient - t \le 10 s (Note 1)$	$R_{\theta JA}$	55	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

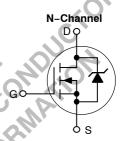
- Surfacemounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- 2. Surfacemounted on FR4 board using the minimum recommended pad size.



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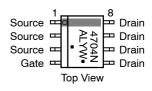
V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX
30 V	7.5 mΩ @ 10 V	12.3 A
30 V	10 mΩ @ 4.5 V	12.57



MARKING DIAGRAM/ PIN ASSIGNMENT



SO-8 CASE 751 STYLE 12



4704N = Device Code

A = Assembly Location

L = WaferLot Y = Year

WW = Work Week
■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS4704NR2	SO-8	2500/Tape & Reel
NTMS4704NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				<u>-</u>	<u>-</u>	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				28		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 24 \text{ V}$	T _J = 125°C			50	1
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±20 V				±100	nA
ON CHARACTERISTICS (Note 3)			<u> </u>		-		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.0		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J			>	5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	12.3 A		7.5	9.5	mΩ
		V _{GS} = 4.5 V, I _D =	10 A		10	12.5	1
Forward Transconductance	9FS	V _{DS} = 15 V, I _D =	10 A		20		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE		_		5	-	-
Input Capacitance	C _{iss}		10		1225		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz,	V _{DS} = 20 V	0,	580		1
Reverse Transfer Capacitance	C_{rss}		9/, "C	0.0	125		1
Total Gate Charge	Q _{G(TOT)}	700		0/1/1	12	17	nC
Threshold Gate Charge	Q _{G(TH)}		6C		1.6		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15$	V, I _D = 10 A		3.25		1
Gate-to-Drain Charge	Q_{GD}	" 12 O. 112			5.25		1
Gate Resistance	R _G	10 11 Of			1.8		Ω
SWITCHING CHARACTERISTICS (Not	e 4)	7,0,6			-		
Turn-On Delay Time	t _{d(on)}				8.2		ns
Rise Time	tr	V _{GS} = 10 V, V _{DD} = 15 \	/. In = 1.0 A.		5.4		1
Turn-Off Delay Time	^t d(off)	$R_G = 3.0 \Omega$			28.4		1
Fall Time	t _f				10.5		1
DRAIN-SOURCE DIODE CHARACTER	RISTICS					•	
Forward Diode Voltage	V _{SD}		T _J = 25°C		0.75	1.0	V
	200	$V_{GS} = 0 \text{ V}, I_{S} = 2.3 \text{ A}$	T _J = 125°C		0.56		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, \text{ d}_{IS}/\text{d}_{t} = 100 \text{ A}/\mu\text{s}, \\ I_{S} = 2.3 \text{ A}$			35		ns
Charge Time	t _a				18		1
Discharge Time	t _b				17		1
Reverse Recovery Charge	Q _{RR}				33		nC

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES

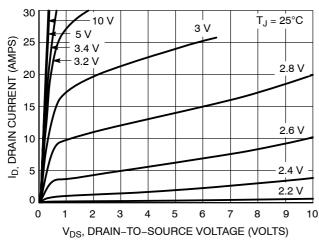


Figure 1. On-Region Characteristics

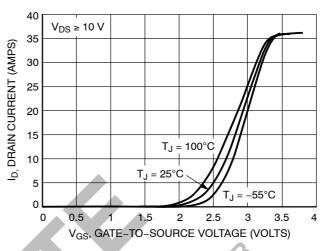


Figure 2. Transfer Characteristics

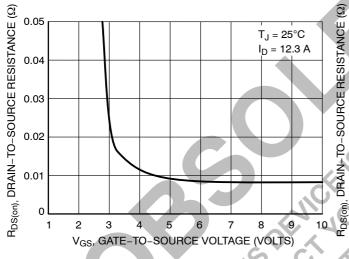


Figure 3. On-Resistance vs. Gate-to-Source Voltage

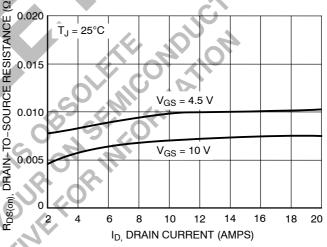


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

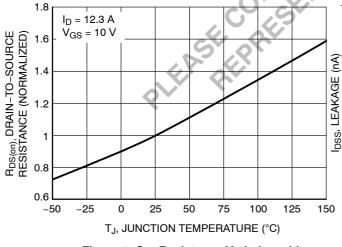


Figure 5. On–Resistance Variation with Temperature

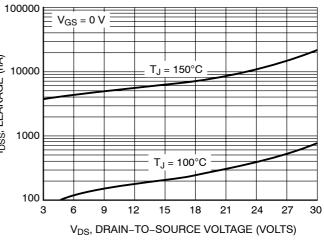
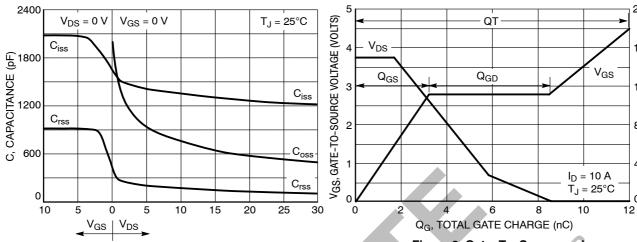


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation



V_{DS} , DRAIN-TO-SOURCE VOLTAGE (VOLTS) 20 6 12 8 4 c

0

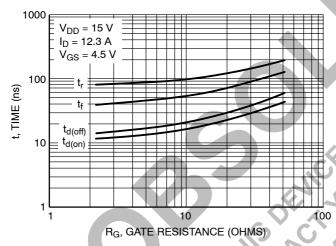


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

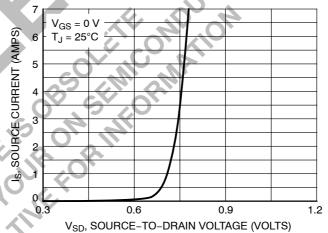
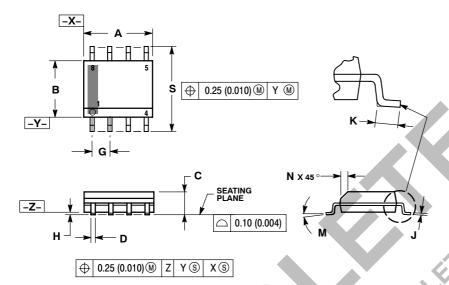


Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

SOIC-8 CASE 751-07 **ISSUE AG**



NOTES:

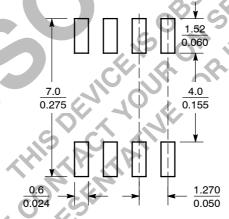
- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07

	MILLIMETERS		INC	CHES		
DIM	MIN MAX		MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
C	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27 BSC		0.05	0 BSC		
Н	0.10	0.25	0.004	0.010		
7	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
M	0 ° 8 °		0 °	8 °		
2	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

- SOURCE PIN 1
- SOURCE
- SOURCE
- GATE
- DRAIN 5. DRAIN
- DRAIN
- DRAIN

SCALE 6:1





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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